

ASYMPTOTIC EFFICIENCIES OF SEQUENTIAL TESTS II

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An asymptotic expression is given for the log error probability of a sequential test based on a random walk. This may be used to compute limiting relative efficiencies of such tests. The results are illustrated for the one-sided normal testing problem with an asymptotic Bayes test due to Schwarz. Some numerical comparisons are given for five sequential tests of a normal mean.

1. Introduction and main results. In a previous paper, Berk (1976), it was argued that relative efficiencies for sequential tests are ratios of certain efficacies, the latter being a limiting ratio of a log error to an expected sample size. (The discussion there is in the context of testing a normal mean, but applies generally.) The limit is taken as the stopping time of the sequential test becomes infinite in a suitable way. We extend the range of applicability of this idea by showing how to evaluate this limit for a large class of sequential tests based on cumulative sums with i.i.d. summands.

Let Y, Y_1, \dots be i.i.d. random variables and let $S_n = Y_1 + \dots + Y_n$. We consider sequential tests with stopping time of the form

$$(1.1) \quad N = \min \{n: S_n \notin (-a\bar{g}_a(n/a), ag_a(n/a))\}.$$

Here g_a and \bar{g}_a are the boundary curves of the continuation region; a is a parameter governing the size of the region. In taking limits, we let $a \rightarrow \infty$. Many sequential tests for one-parameter models have stopping times of the form (1.1). These include SPRTs, LMP sequential tests (Berk (1975)) and asymptotically Bayes sequential tests for one-parameter families (Schwarz (1962), Kiefer and Sacks (1963)). We consider the one-sided (hypothesis) case, for which the appropriate terminal decision, on stopping, is to reject the null hypothesis iff $S_N \geq ag_a(N/a)$. We write this as $(S_N \geq g)$ for short. (Implicit in our notation is that $-\bar{g}_a \leq g_a$.) Interest then centers on the error probability, which is $P(S_N \geq g)$ or $P(S_N \leq -\bar{g})$ depending on which hypothesis obtains. We work explicitly with the former probability; it is seen, on replacing Y by $-Y$ and interchanging boundaries, that the results apply to the latter as well. Our considerations apply to an upper boundary that has an asymptotic shape: As $a \rightarrow \infty$, $g_a(x) \rightarrow g(x)$ for $x > 0$. (In fact, we suppose that g_a decreases to g .)

We suppose that under the distribution of interest, $EY < 0$. We also suppose that $Ee^{tY} < \infty$ for some $t > 0$. Then $b(t) = \log Ee^{tY}$ is finite in some neighborhood of zero. It is well known that b is convex and analytic on the

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interior of the interval ($b < \infty$). Let $\beta(r) = \sup \{tr - b(t) : t \in R\}$; β is the convex function dual to b (Rockafellar (1970)). Since $EY = b'(0) < 0$, for $r > 0$, $\beta(r) = \sup \{tr - b(t) : t > 0\}$. Also, let $R(x) = g(x)/x$. We say $g \in \mathcal{G}$ if the following holds: for some $0 < \nu \leq \infty$, $0 \leq R$ is strictly decreasing on $(0, \nu) = (R > 0)$, $\lim_{x \rightarrow 0} R(x) = \infty$ and $\lim_{x \rightarrow \infty} R(x) = 0$.

Under certain conditions on the distribution of Y and the boundary curves, we show that as $a \rightarrow \infty$,

$$(1.2) \quad \log P(S_N \geq g) \sim \max_n \log P(S_n \geq ag_a(n/a)).$$

That is, to first order, the log probability of the sequentially determined event $(S_N \geq g)$ is determined by the point of the upper boundary "closest" to the random walk $\{S_n\}$; closest in that the probability of crossing there is maximum (but regardless of the past history of the walk). The following theorem paraphrases (1.2).

THEOREM. Let $R_a(x) = g_a(x)/x \in \mathcal{G}$ and suppose too that as $a \uparrow \infty$, $R_a(x)$ decreases to $R(x) = g(x)/x \in \mathcal{G}$. Suppose also that for each fixed $n = 1, 2, \dots$, $\lim_a a\bar{g}_a(n/a) = \infty$. Letting $b(t) = \log Ee^{tY}$, suppose that $(b < \infty)$ is an open interval containing zero and that $EY < 0$. Then as $a \rightarrow \infty$,

$$(1.3) \quad \log P(S_N \geq g) \sim -a\kappa,$$

where

$$(1.4) \quad \kappa = \inf_{x>0} x\beta(R(x)) = \inf_{x>0} \inf_t x[tR(x) - b(t)].$$

PROOF. We observe first that

$$\begin{aligned} P(S_n \geq ag_a(n/a)) &= P(S_n \geq nR_a(n/a)) \\ &\leq P(S_n \geq nR(n/a)) \leq \inf_{t>0} E \exp\{tS_n - ntR(n/a)\} \\ &= \inf_t \exp\{nb(t) - ntR(n/a)\} = \exp\{-n\beta(R(n/a))\}. \end{aligned}$$

Hence

$$\begin{aligned} \max_n P(S_n \geq ag_a(n/a)) &\leq \max_n \exp\{-n\beta(R(n/a))\} \\ &\leq \sup_{x>0} \exp\{-ax\beta(R(x))\} = e^{-a\kappa}. \end{aligned}$$

Repeating the above argument with R replaced by zero gives

$$P(S_n \geq ag_a(n/a)) \leq P(S_n \geq 0) \leq \inf_{t>0} \exp\{nb(t)\} = e^{-n\rho},$$

where $-\rho = \inf_t b(t) < 0$. (That $\inf_{t>0} b(t) = \inf_t b(t) < 0$ follows from the fact that $b'(0) < 0$, together with the fact that $b(0) = 0$.) Letting $k = \kappa/\rho$,

$$(1.5) \quad \begin{aligned} P(S_N \geq g) &\leq \sum_{n=1}^{\infty} P(S_n \geq ag_a(n/a)) \\ &\leq ake^{-a\kappa} + \sum_{n>ak} e^{-n\rho} = \exp\{-a\kappa + o(a)\}. \end{aligned}$$

For $t \in (b < \infty)$, let P_t denote the distribution of the i.i.d. sequence Y, Y_1, \dots when they marginally have pdf $\exp\{ty - b(t)\}$ with respect to P . Let $\mu_t = b'(t) = E_t Y$. That $(b < \infty)$ is open insures that μ_t ranges (continuously and

strictly monotonically) in $(-\infty, \infty)$ for $t \in (b < \infty)$. As is well known, the likelihood ratio for the sequentially obtained data is

$$dP_t^N/dP^N = \exp\{tS_N - Nb(t)\}.$$

The conditions on g_a entail $P_t(N < \infty) = 1$ when $\mu_t > 0$ (for a sufficiently large) and then

$$(1.6) \quad P(S_N \geq g) = \int_{(S_N \geq g)} \exp\{-tS_N + Nb(t)\} dP_t, \quad \mu_t > 0.$$

Under the assumptions on g_a and \bar{g}_a , for $\mu_t > 0$, $P_t(\lim_a 1_{(S_N \geq g)} = 1) = 1$, so also $\lim_a P_t(S_N \geq g) = 1$. Moreover, the inequalities

$$(1.7) \quad S_{N-1}/N < R_a(N/a - 1/a), \quad (S_N/N)1_{(S_N \geq g)} \geq R(N/a)1_{(S_N \geq g)}$$

entail

$$(1.8) \quad P_t(\lim_a N/a = R^{-1}(\mu_t)) = 1 \quad \text{if} \quad \mu_t > 0$$

as follows: we note that $P_t(\lim_a N = \infty) = 1$, so that $P_t(\lim_a S_N/N = \mu_t) = 1$. Thus (1.7) entails

$$(1.9) \quad \limsup_a R(N/a) \leq \mu_t \leq \liminf_a R_a(N/a - 1/a) \quad [P_t],$$

which in turn implies (1.8). (Since R is strictly decreasing, there is no ambiguity in defining R^{-1} . Note that $R(N/a)$ need not tend to μ_t for P_t unless R is continuous at $R^{-1}(\mu_t)$.)

To finish the proof, we need the following lemma which is proved in Berk (1976); cf. Lemma 7.3.

LEMMA. *Let V_a be an indexed set of random variables so that for some constant v , $V_a/a \rightarrow_P v$ as $a \rightarrow \infty$. Let B_a be any indexed set of events for which $\liminf_a PB_a > 0$. Then*

$$(1.10) \quad \int_{B_a} \exp\{V_a\} dP \geq \exp\{av + o(a)\}.$$

We apply the lemma to $V_a = tS_N - Nb(t)$, the exponent in (1.6). It follows from (1.8) that w.p. 1 for P_t , $V_a/a \rightarrow R^{-1}(\mu_t)[t\mu_t - b(t)]$. Recall that $\beta(r) = \sup_s \{sr - b(s)\}$. If $r = \mu_t$, the derivative of the concave function $f(s) = sr - b(s)$ vanishes at $s = t$, so that $\beta(\mu_t) = t\mu_t - b(t)$. Thus $V_a/a \rightarrow \beta(\mu_t) [P_t]$. Since $P_t(S_N \geq g) \rightarrow 1$ for $\mu_t > 0$, (1.6) and (1.10) entail

$$\liminf_a a^{-1} \log P(S_N \geq g) \geq -R^{-1}(\mu_t)\beta(\mu_t), \quad \mu_t > 0,$$

hence that

$$(1.11) \quad \liminf_a a^{-1} \log P(S_N \geq g) \geq \sup \{-R^{-1}(\mu_t)\beta(\mu_t) : \mu_t > 0\} \\ = -\inf_{x>0} x\beta(R(x)) = -\kappa.$$

Together, (1.5) and (1.11) establish the theorem. \square

When $EY > 0$, the corresponding result is

$$(1.12) \quad \log P(S_N \leq -\bar{g}) \sim -a\bar{\kappa},$$

where

$$(1.13) \quad \bar{\kappa} = \inf_{x>0} x\beta(\bar{R}(x)) = \inf_{x>0} \sup_t x[t\bar{R}(x) - \bar{b}(t)] .$$

Here $\bar{b}(t) = b(-t)$ and \bar{R} is the R -function for the lower boundary.

2. Discussion. The preceding applies to exponential families as follows. Suppose that under P , Y marginally has pdf $\exp\{\theta y - c(\theta)\}$ with respect to some underlying measure. Then $b(t) = c(t + \theta) - c(\theta)$ and if $\eta(r) = \sup_t [tr - c(t)]$ denotes the function dual to c ,

$$(2.1) \quad \begin{aligned} \kappa &= \inf_{x>0} \sup_t x[tR(x) - c(t + \theta) + c(\theta)] \\ &= \inf_{x>0} x[\eta(R(x)) + c(\theta) - \theta R(x)] , \quad EY < 0 \end{aligned}$$

and

$$(2.2) \quad \bar{\kappa} = \inf_{x>0} x[\bar{\eta}(\bar{R}(x)) + c(\theta) + \theta \bar{R}(x)] , \quad EY > 0 .$$

When $Y \sim N(\theta, 1)$, $c(\theta) = \bar{c}(\theta) = \eta(\theta) = \frac{1}{2}\theta^2$ and these become

$$(2.3) \quad \begin{aligned} \kappa &= \inf_{x>0} \frac{1}{2}x(R(x) - \theta)^2 , \quad \theta < 0 \\ \bar{\kappa} &= \inf_{x>0} \frac{1}{2}x(\bar{R}(x) + \theta)^2 , \quad \theta > 0 . \end{aligned}$$

In Berk (1976), κ was evaluated by different methods for the continuous-time normal case. Equation (2.3) shows that those results apply to discrete time as well. As a complement to the results of Berk (1976), we consider the continuation region given by $g_a(x) = \bar{g}_a(x) = (2x)^{\frac{1}{2}} - \mu x$. As shown by Schwarz (1962), this is the asymptotic shape of the Bayes test of $H_1: \theta \leq 0$ vs $H_2: \theta > 0$ in the normal case (variance = one) when the prior for θ dominates Lebesgue measure and when $(-\mu, \mu)$ is an indifference region. (Schwarz did not show that the corresponding procedure defined by

$$(2.4) \quad N = \min \{n: |S_n| \geq (2an)^{\frac{1}{2}} - \mu n\}$$

is asymptotically optimal (Bayes), although this follows from the results of Kiefer and Sacks (1963).) In this case $R(x) = \bar{R}(x) = (2/x)^{\frac{1}{2}} - \mu$ and (2.3) becomes

$$(2.5) \quad \begin{aligned} \kappa &= 2^{\frac{1}{2}}\theta\mu , \quad 0 < \theta \leq \mu \\ &= 2^{\frac{1}{2}} , \quad \theta > \mu . \end{aligned}$$

Let $\varepsilon(\theta)$ denote the probability of error of a sequential test when θ obtains. It is suggested in Berk (1976) that the limits (as $a \rightarrow \infty$) of $[-\log \varepsilon(\theta)]/E_\theta N$ and $[-\log \varepsilon(\theta)]/E_0 N$ are efficacies for judging the relative efficiency of the test. (As in other cases, the ratio of corresponding efficacies for two tests gives their relative efficiency. Using $E_0 N$ as a divisor is akin to standardizing tests to have the same level.) Using (1.8) for N defined by (2.4), we see that under P_θ , $N/a \rightarrow 2/(\mu + |\theta|)^2$. Since N/a is bounded, also

$$E_\theta N \sim 2a/(\mu + |\theta|)^2 ,$$

TAPO

θ	0	.1	.2	.3	.4	.5	.6	.7	.8	.9	1.0
$\varepsilon(\theta)$.5	.256	9.91 (-2)	3.22 (-2)	1.12 (-2)	4.80 (-3)	2.35 (-3)	1.20 (-3)	6.20 (-4)	3.24 (-4)	1.71 (-4)
$E_\theta N$	36.8	34.9	29.7	23.2	17.4	13.1	10.1	8.2	6.8	5.8	5.1
$\tilde{e}(\theta)$	1.88 (-2)	3.91 (-2)	7.79 (-2)	.148	.258	.408	.597	.822	1.08	1.38	1.71
$e(\theta)$	0*	.005	.02	7.39 (-2)	.222	.373	.567	.804	1.08	1.40	1.77
$\tilde{e}_0(\theta)$	1.88 (-2)	3.70 (-2)	6.28 (-2)	9.32 (-2)	.122	.145	.164	.183	.201	.218	.235
$e_0(\theta)$	0*	.005*	.02*	.045*	.08*	9.11 (-2)	.102	.113	.123	.134	.144

ANDERSON

θ	0	.1	.2	.3	.4	.5	.6	.7	.8	.9	1.0
$\varepsilon(\theta)$.5	.267	.107	3.21 (-2)	7.23 (-2)	1.27 (-3)	1.82 (-4)	2.46 (-5)	3.05 (-6)	3.71 (-7)	4.49 (-8)
$E_\theta N$	28.3	27.1	24.2	20.8	17.8	15.4	13.5	12.0	10.9	9.9	9.1
$\tilde{e}(\theta)$	2.45 (-2)	4.90 (-2)	9.20 (-2)	.165	.277	.434	.638	.881	1.17	1.49	1.86
$e(\theta)$	0	7.5 (-2)	.04	.112	.24	.42	.64	.9	1.2	1.54	1.92
$\tilde{e}_0(\theta)$	2.45 (-2)	4.67 (-2)	7.89 (-2)	.122	.174	.236	.304	.375	.449	.523	.598
$e_0(\theta)$	0*	.005*	.02*	.045*	.08*	.12	.16	.2	.24	.28	.32

SCHWARZ

θ	0	.1	.2	.3	.4	.5	.6	.7	.8	.9	1.0
$\varepsilon(\theta)$.5	.288	.135	5.47 (-2)	2.11 (-2)	8.75 (-3)	4.16 (-3)	2.22 (-3)	1.27 (-3)	7.63 (-4)	4.70 (-4)
$E_\theta N$	21.5	20.5	18.1	15.1	12.4	10.2	8.5	7.2	6.2	5.4	4.8
$\tilde{e}(\theta)$	3.22 (-2)	6.07 (-2)	.111	.193	.312	.466	.645	.848	1.08	1.33	1.61
$e(\theta)$	0*	7.81 (-3)	.045	.138	.32*	.405	.5	.605	.72	.845	.98
$\tilde{e}_0(\theta)$	3.22 (-2)	5.79 (-2)	9.29 (-2)	.135	.179	.220	.255	.284	.310	.334	.356
$e_0(\theta)$	*0	.005*	.02*	.045*	.08*	.08	.08	.08	.08	.08	.08

Schwarz test is discussed above. For the Schwarz test, μ was chosen to be 0.4 and $a = 4.0$. Thus

$$N_{\text{SCH}} = \min \{n: |S_n| \geq (8n)^{\frac{1}{2}} - 0.4n\}.$$

It is easily seen that $N \leq m = 50$. The boundaries for the other tests were chosen so as to circumscribe the Schwarz continuation region. This is because, asymptotically, any such region has the same log error rate at $\pm\mu$ as the Schwarz procedure and an $E_0 N$ (= maximum expected sample size) which is, to first

order, as small as possible; cf. Berk (1977). Thus

$$\begin{aligned} N_{\text{SPRT}} &= \min \{n: |S_n| \geq 5\} \\ N_{\text{TFRT}} &= N_{\text{SPRT}} \wedge 50 \\ N_{\text{AND}} &= \min \{n: |S_n| \geq 10 - 0.2n\} \leq 50 \\ N_{\text{TAPO}} &= \min \{n: |S_n| \geq (2.532n + 6.331)^{1/2}\} \wedge 50. \end{aligned}$$

The null hypothesis is rejected if $S_N \geq 0$. For these tests the probability of error $\varepsilon(\theta)$ and the expected sample size were computed for $\theta = 0(0.1)1.0$. This was done using successive convolutions, a procedure alluded to by Aroian (1968) as the "direct method"; see Aroian and Robinson (1969). From these values we obtain the actual efficacies (ratios of log error to expected sample size), $\bar{e}(\theta)$ and $\bar{e}_0(\theta)$, which may be compared with the limiting values given in the tables below. Values of the limiting efficacies that achieve the appropriate bound $2\theta^2$ or $\frac{1}{2}\theta^2$ are marked with an asterisk.

The tables indicate a good qualitative agreement between the actual and limiting efficacies and reasonably good quantitative agreement in most cases. The values for $\bar{e}(\theta)$ agree better with their limiting values than those for $\bar{e}_0(\theta)$. In part, this can be attributed to the fact that $E_0 N$ appears to tend to its limiting value rather slowly. In all of the above tests $E_0 N \sim m$, the common truncation value, but the actual $E_0 N$ is substantially less in all cases. Nevertheless, the agreement is good enough to warrant guarded optimism that the limiting efficacies do represent the actual characteristics of the test.

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